## **Square-Law Equations**

For a triode-operating long-channel NMOS device

$$I_D = KP_n \cdot \frac{W}{L} \cdot \left| (V_{GS} - V_{THN}) V_{DS} - \frac{V_{DS}^2}{2} \right|$$

for 
$$V_{GS} \ge V_{THN}$$
 and  $V_{DS} \le V_{GS} - V_{THN}$ 

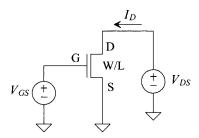
For a long-channel NMOS device operating in the saturation region:

$$I_D = \frac{KP_n}{2} \cdot \frac{W}{L} (V_{GS} - V_{THN})^2 [1 + \lambda (V_{DS} - V_{DS,sat})]$$

for 
$$V_{GS} > V_{THN}$$
 and  $V_{DS} \ge V_{GS} - V_{THN}$ 

On the border between saturation and triode:

 $V_{DS,sat} = V_{GS} - V_{THN}$  and the drain current is called  $I_{D,sat}$ , see Fig. 6.11



For the PMOS device equations make the following substitutions in the equations listed above

$$V_{DS} \rightarrow V_{SD}$$
,  $V_{GS} \rightarrow V_{SG}$ , and  $V_{THN} \rightarrow V_{THP}$ .

All of the voltages and currents in the PMOS and NMOS equations are **positive**. For example, for the PMOS device to conduct a drain current requires  $V_{SG} > V_{THP}$ . For the NMOS to conduct a drain current requires  $V_{GS} > V_{THN}$ .

